

### General Description

- Trench Power MV MOSFET technology
- Low  $R_{DS(ON)}$
- Logic Level Driving
- RoHS and Halogen-Free Compliant

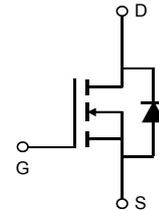
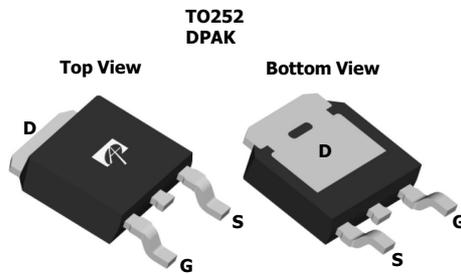
### Applications

- Industrial and Motor Drive applications

### Product Summary

|                                  |                |
|----------------------------------|----------------|
| $V_{DS}$                         | 60V            |
| $I_D$ (at $V_{GS}=10V$ )         | 40A            |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 18m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 23m $\Omega$ |

100% UIS Tested  
 100% Rg Tested



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOD442G               | TO-252       | Tape & Reel | 2500                   |

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol         | Maximum                 | Units            |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$       | 60                      | V                |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 20$                | V                |
| Continuous Drain Current                       | $I_D$          | $T_C=25^\circ\text{C}$  | 40               |
|  |                | $T_C=100^\circ\text{C}$ | 25.5             |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$       | 90                      | A                |
| Continuous Drain Current                       | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | 13               |
|  |                | $T_A=70^\circ\text{C}$  | 10.5             |
| Avalanche Current <sup>C</sup>                 | $I_{AS}$       | 30                      | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}$       | 45                      | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$          | $T_C=25^\circ\text{C}$  | 60               |
|  |                | $T_C=100^\circ\text{C}$ | 24               |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 6.2              |
|  |                | $T_A=70^\circ\text{C}$  | 4.0              |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter  | Symbol          | Typ | Max | Units              |
|--|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> $t \leq 10\text{s}$ | $R_{\theta JA}$ | 15  | 20  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> Steady-State      |                 | 40  | 50  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case Steady-State                        | $R_{\theta JC}$ | 1.7 | 2.1 | $^\circ\text{C/W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min | Typ        | Max      | Units |
|-----------------------------|---------------------------------------|---|-----|------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |            |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 60  |            |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =60V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |            | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |     |            | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 1.5 | 2.1        | 2.7      | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                        |     | 14<br>24.5 | 18<br>32 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A  |     | 17         | 23       |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A  |     | 62         |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.7        | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |     |            | 40       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |            |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz   |     | 1920       |          | pF    |
| C <sub>Oss</sub>            | Output Capacitance                    |   |     | 155        |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   |     | 115        |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | f=1MHz  | 0.3 | 0.65       | 1.1      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |            |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =20A                           |     | 47.5       | 68       | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |   |     | 24         | 35       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |     | 6          |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |     | 14.5       |          | nC    |
| Q <sub>Oss</sub>            | Output Charge                         | V <sub>GS</sub> =0V, V <sub>DS</sub> =30V   |     | 8          |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, R <sub>L</sub> =1.5Ω,<br>R <sub>GEN</sub> =3Ω |     | 8          |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |   |     | 5          |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |   |     | 30         |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |     | 5.5        |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, di/dt=500A/μs  |     | 30         |          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, di/dt=500A/μs  |     | 105        |          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

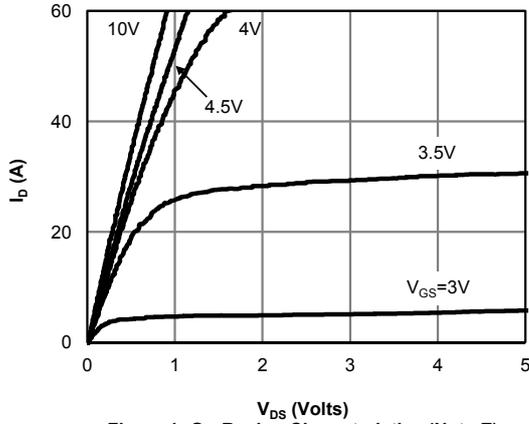
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

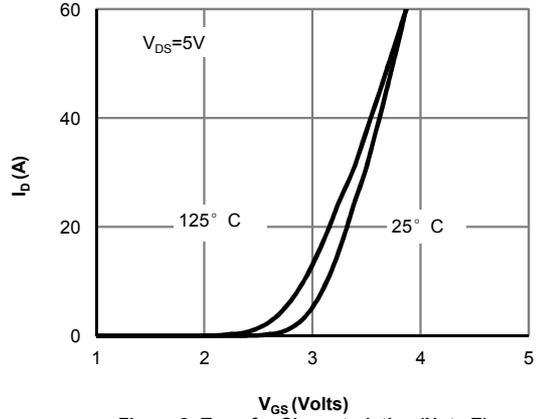
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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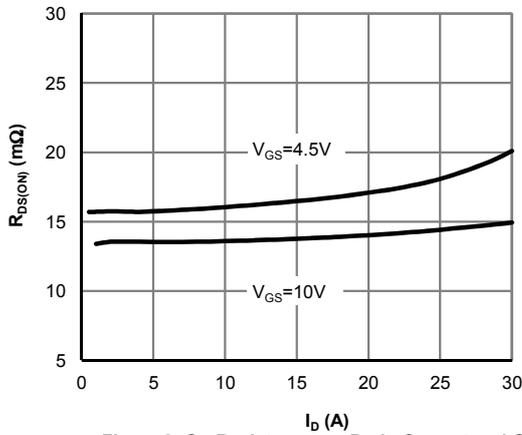
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



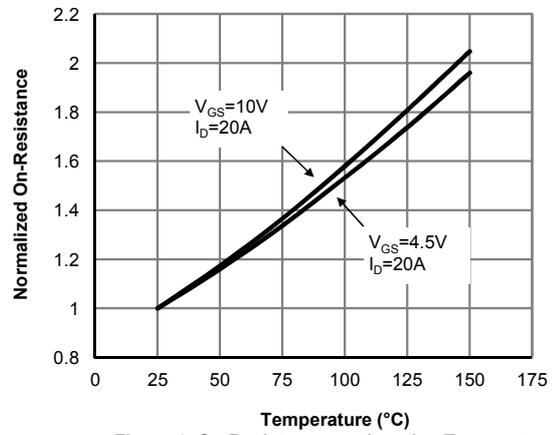
**Figure 1: On-Region Characteristics (Note E)**



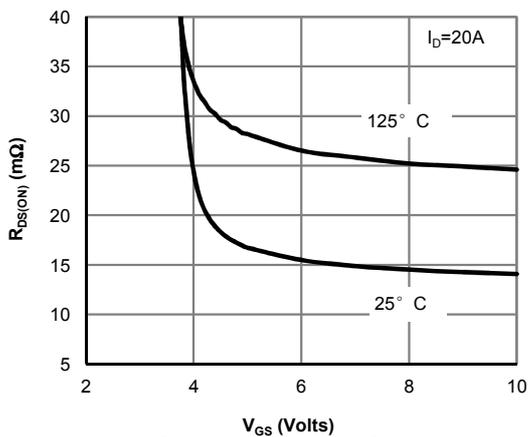
**Figure 2: Transfer Characteristics (Note E)**



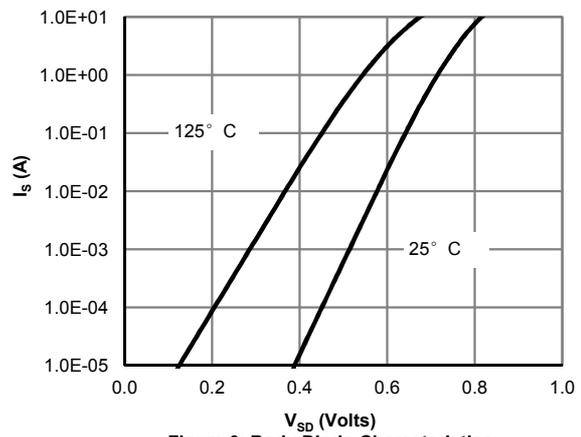
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

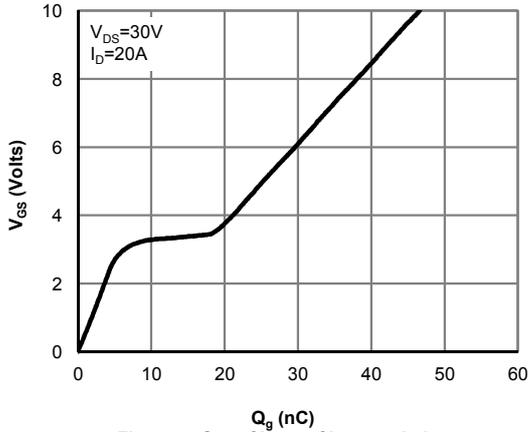


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

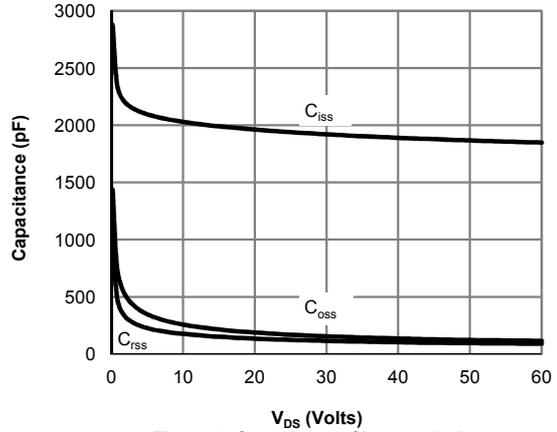


**Figure 6: Body-Diode Characteristics (Note E)**

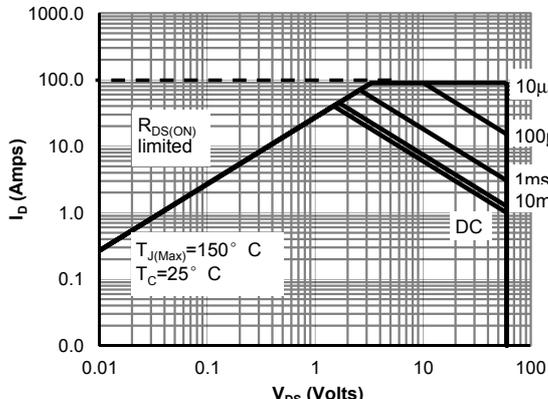
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



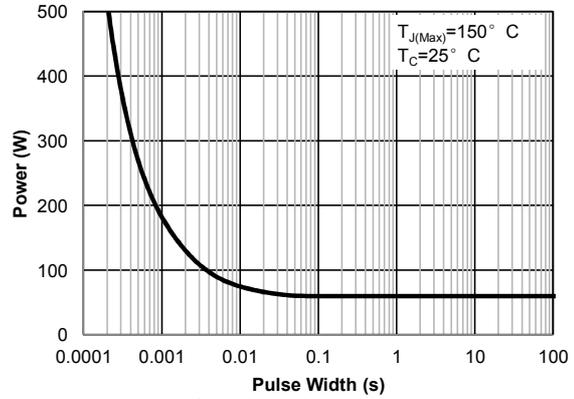
**Figure 7: Gate-Charge Characteristics**



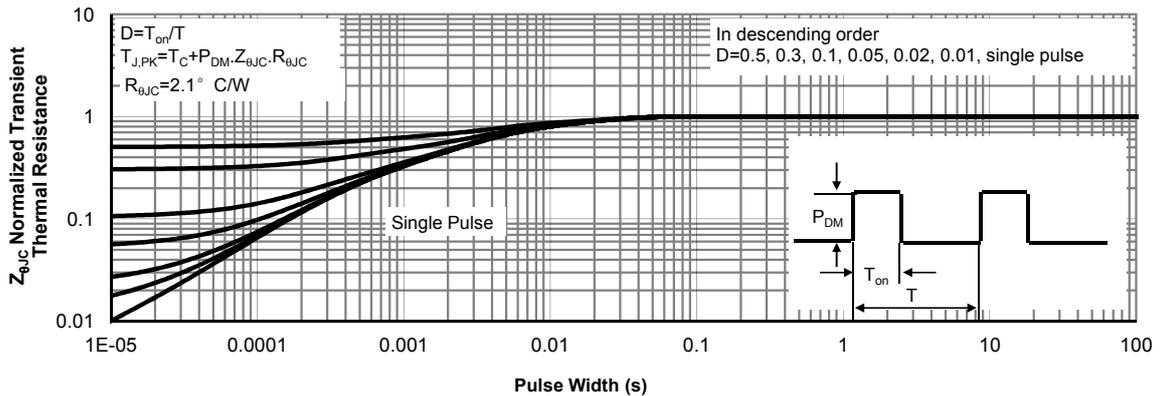
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**  
 $V_{GS} > \text{or equal to } 4.5V$



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

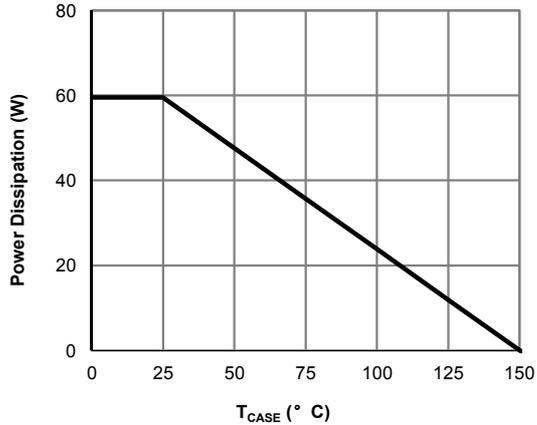


Figure 12: Power De-rating (Note F)

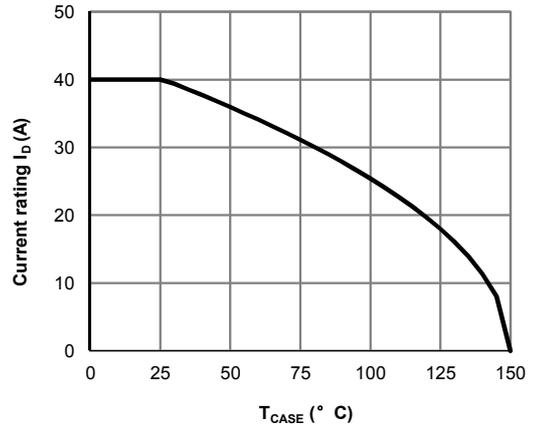


Figure 13: Current De-rating (Note F)

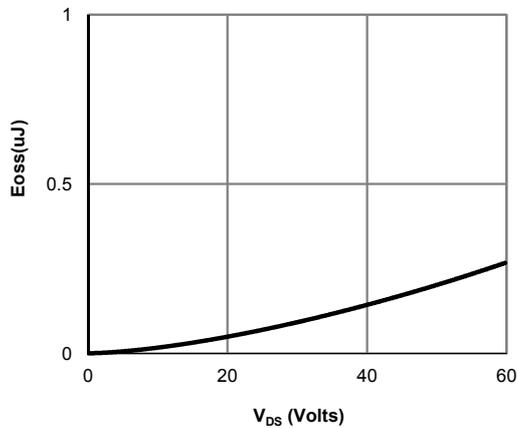


Figure 14: Coss stored Energy

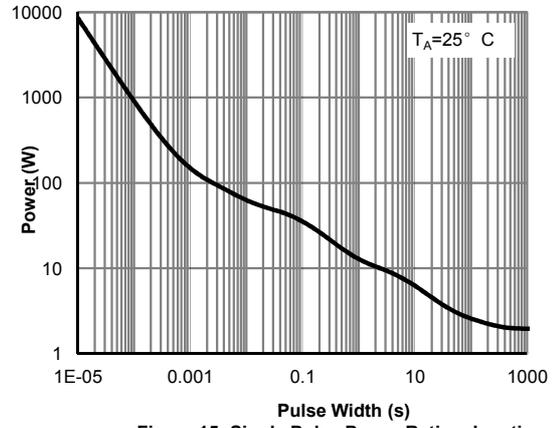


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

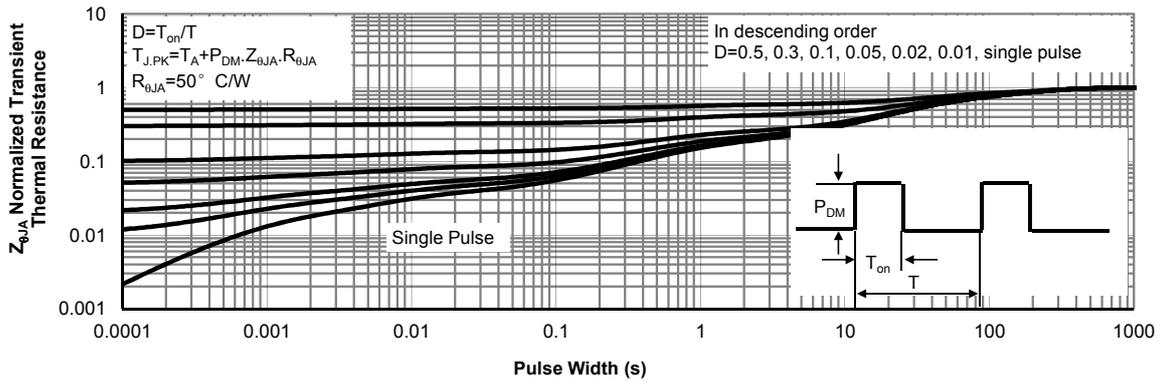


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

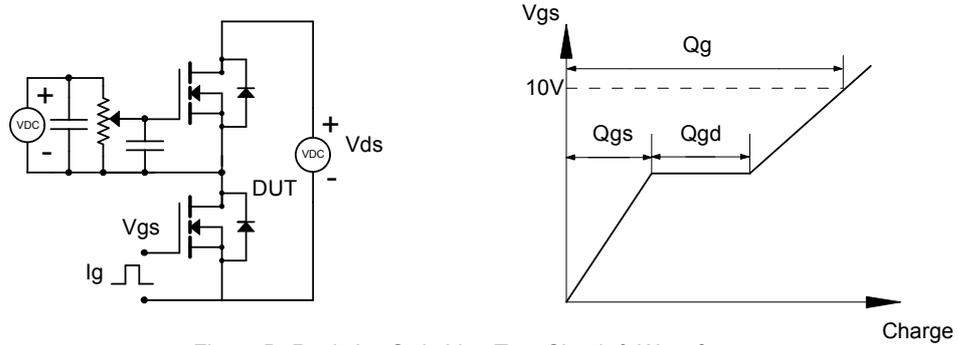


Figure B: Resistive Switching Test Circuit & Waveforms

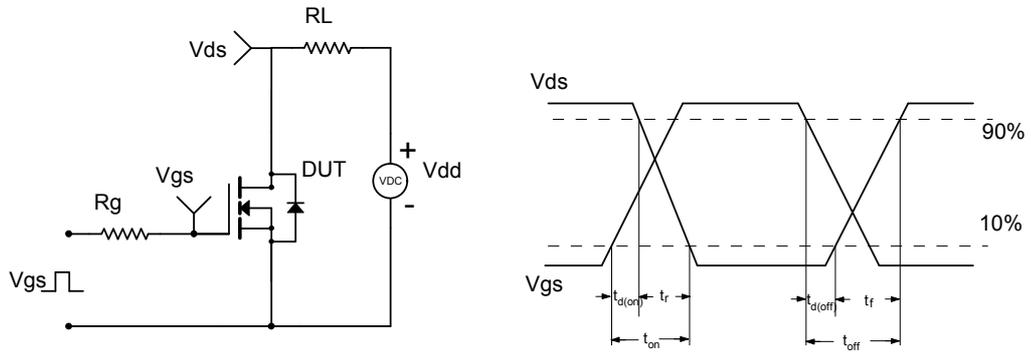


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

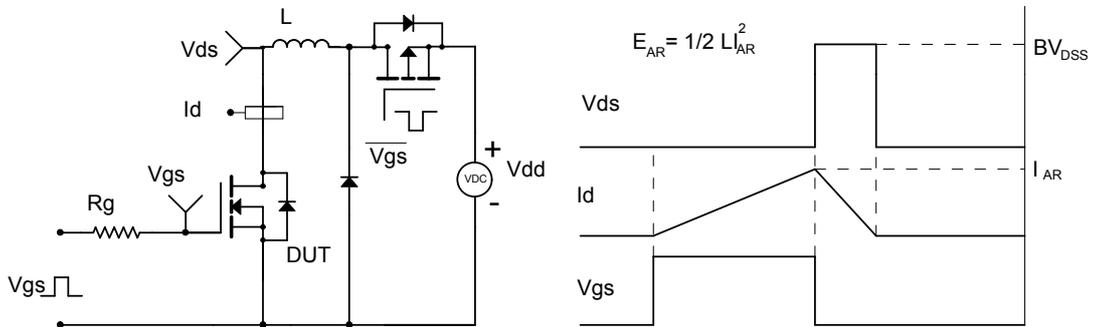


Figure D: Diode Recovery Test Circuit & Waveforms

